

Silicon Carbide (SiC) Schottky Diode - EliteSiC. 50 A, 650 V, D1, Die

PCFFS5065AF

Description

Silicon Carbide (SiC) Schottky Diodes use a completely new technology that provides superior switching performance and higher reliability compared to Silicon. No reverse recovery current, temperature dependent switching characteristics, and excellent thermal performance sets Silicon Carbide as the next generation of power semiconductor. System benefits include highest efficiency, faster operation frequency, increased power density, reduced EMI, and reduced system size and cost.

Features

- Max Junction Temperature 175°C
- Avalanche Rated 240 mJ
- High Surge Current Capacity
- Positive Temperature Coefficient
- Ease of Paralleling
- No Reverse Recovery/No Forward Recovery

Applications

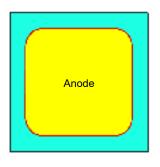
- General Purpose
- SMPS, Solar Inverter, UPS
- Power Switching Circuits

Die Information

- Wafer Diameter: 6 inch
- NOT RECONTACT YOUR Scrib • Die Size: 3,350 × 3,350 um (include Scribe Lane)
- Metallization:
 - ◆ Top 40KA 0.5%AlCu
 - ◆ Back 0.5K Ti + 3K Ni/V + 1.5K Ag
- Die Thickness: Typ. 200 μm
- Bonding Pad Size
 - Anode 2,990 × 2,990 μm
- Recommended Wire Bond (Note 1)
 - Anode: $20 \text{ mil} \times 2$

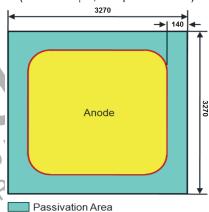
NOTE:

1. Based on TO-247 package of onsemi.



DIE LAYOUT

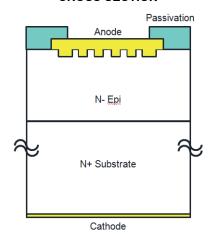
(Dimension: µm, Except Scribe Lane)



Passivation Information

- Passivation Material: Polymide (PSPI)
- Passivation Type: Local Passivation
- Passivation Thickness: 90KA

CROSS SECTION



ORDERING INFORMATION

Part Number	Package	Die Size			
PCFFS5065AF	N/A	3,350 x 3,350 μm (Include Scribe Lane)			

1

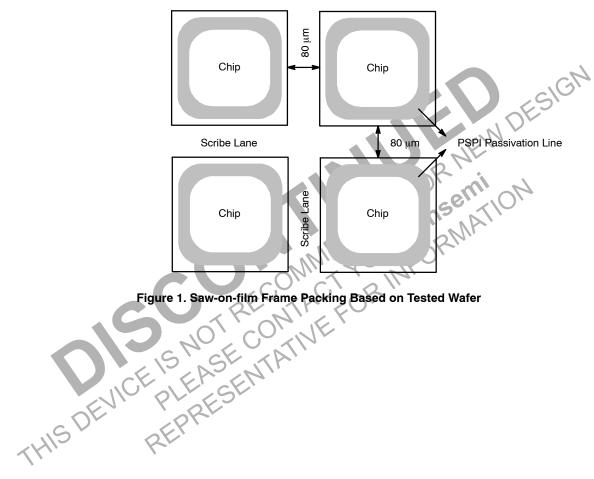
ELECTRICAL CHARACTERISTICS ON WAFER (T_C = 25°C unless otherwise noted) (Note 2)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit	
V _R	Reverse Blocking Voltage	$I_R = 200 \ \mu A, T_C = 25^{\circ}C$	650	-	_	V	
V _F	Forward Voltage	I _F = 50 A, T _C = 25°C	1.20	-	1.75	V	
I _R	Reverse Current	$V_R = 650 \text{ V}, T_C = 25^{\circ}\text{C}$	-	ı	200	μΑ	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Tested 100% on wafer.

The Configuration of Chips (Based on 6" Wafer)



ABSOLUTE MAXIMUM RATINGS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	FFSH4065A	Unit	
V_{RRM}	Peak Repetitive Reverse Voltage	650	V	
E _{AS}	Single Pulse Avalanche Energy (Note 3)		240	mJ
I _F	Continuous Rectified Forward Current @ T _C <	144°C	50	Α
	Continuous Rectified Forward Current @ T _C <	60		
I _{F, Max}	Non-Repetitive Peak Forward Surge Current	T _C = 25°C, 10 μs	1350	Α
		T _C = 150°C, 10 μs	1250	Α
I _{F,SM}	Non-Repetitive Forward Surge Current	Half-Sine Pulse, t _p = 8.3 ms	230	Α
I _{F,RM}	Repetitive Forward Surge Current	Half-Sine Pulse, t _p = 8.3 ms	95	Α
Ptot	Power Dissipation	T _C = 25°C		W
		T _C = 150°C	72	W
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +175	U °C
	TO247 Mounting Torque, M3 Screw	60	Ncm	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 3. E_{AS} of 240 mJ is based on starting $T_J = 25^{\circ}C$, L = 0.5 mH, $I_{AS} = 31$ A, V = 50 V.

THERMAL CHARACTERISTICS

	Symbol	Parameter),	an	Value	Unit
ĺ	$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max (Note 4)		(O)	Š		0.35	°C/W

^{4.} Pulse: Test Pulse width = 300 μs, Duty Cycle = 2%

$\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
V _F	Forward Voltage	I _F = 50 A, T _C = 25°C	0/-	1.51	1.75	V
	16	I _F = 50 A, T _C = 125°C	_	1.67	2.0	
	al - N	I _F = 50 A, T _C = 175°C	_	1.82	2.4	
I _R	Reverse Current	$V_R = 650 \text{ V}, T_C = 25^{\circ}\text{C}$	-	ı	200	μΑ
	"CF"E	V _R = 650 V, T _C = 125°C	_	-	400	
	OF VICE	V _R = 650 V, T _C = 175°C	_	-	600	
Q _C	Total Capacitive Charge	V = 400 V	_	147	_	nC
C	Total Capacitance	V _R = 1 V, f = 100 kHz	_	2530	_	pF
		V _R = 200 V, f = 100 kHz	_	271	_	
		V _R = 400 V, f = 100 kHz	_	211	_	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

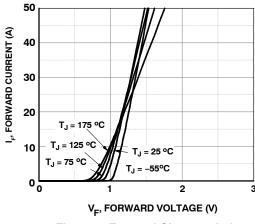


Figure 2. Forward Characteristics

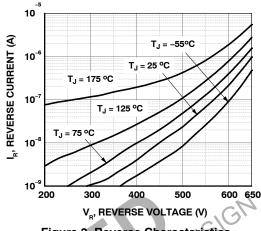


Figure 3. Reverse Characteristics

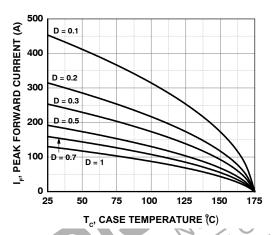


Figure 4. Current Derating

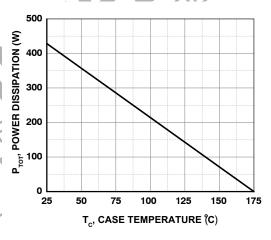


Figure 5. Power Derating

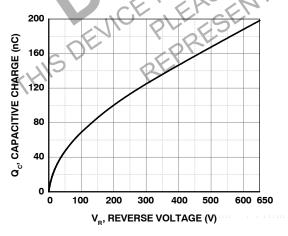


Figure 6. Capacitive Charge vs. Reverse Voltage

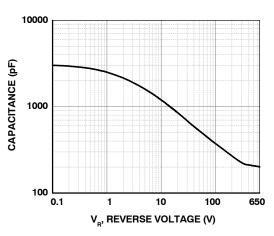


Figure 7. Capacitance vs. Reverse Voltage

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

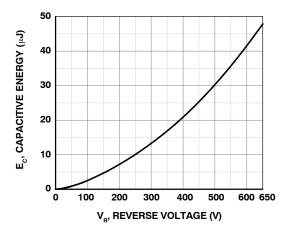
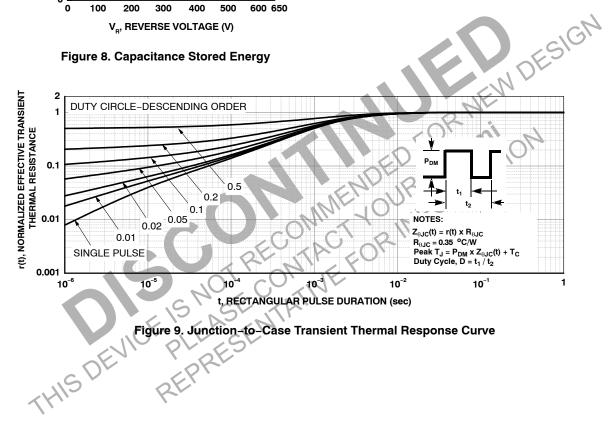
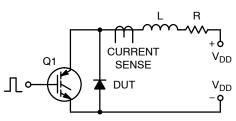


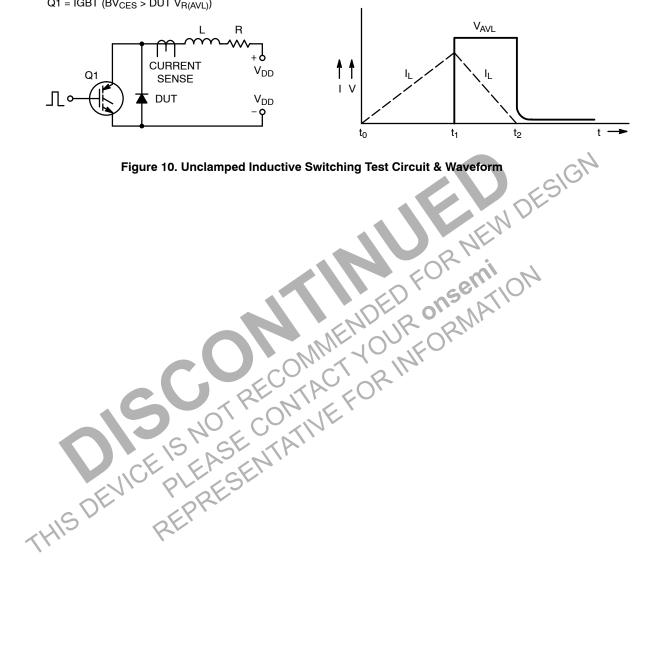
Figure 8. Capacitance Stored Energy



TEST CIRCUIT AND WAVEFORMS

L = 0.5 mH $R < 0.1 \Omega$ $V_{DD} = 50 \text{ V}$
$$\begin{split} &\mathsf{EAVL} = 1/2\mathsf{L}12 \left[\mathsf{V}_{\mathsf{R}(\mathsf{AVL})} \ / \ (\mathsf{V}_{\mathsf{R}(\mathsf{AVL})} - \mathsf{V}_{\mathsf{DD}}) \right] \\ &\mathsf{Q1} = \mathsf{IGBT} \ (\mathsf{BV}_{\mathsf{CES}} > \mathsf{DUT} \ \mathsf{V}_{\mathsf{R}(\mathsf{AVL})}) \end{split}$$





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